

$V_{DRM}$	= 5600	V
$V_{DSM}$	= 6500	V
$I_{T(AV)M}$	= 350	A
$I_{T(RMS)}$	= 550	A
$I_{TSM}$	= $4.5 \times 10^3$	A
$V_{(T0)}$	= 1.2	V
$r_T$	= 2.3	mW

# Phase Control Thyristor

**5STP 03X6500**

Doc. No. 5SYA1003-04 Oct. 04

- Patented free-floating silicon technology
- Low on-state and switching losses
- Designed for traction, energy and industrial applications
- Optimum power handling capability
- Interdigitated amplifying gate

## Blocking

Maximum rated values <sup>1)</sup>

Symbol	Conditions	5STP 03X6500	5STP 03X6200	5STP 03X5800
$V_{DSM}, V_{RSM}$	$f = 5 \text{ Hz}, t_p = 10 \text{ ms}$	6500 V	6200 V	5800 V
$V_{DRM}, V_{RRM}$	$f = 50 \text{ Hz}, t_p = 10 \text{ ms}$	5600 V	5300 V	4900 V
$V_{RSM}$	$t_p = 5 \text{ ms, single pulse}$	7000 V	6700 V	6300 V
$dV/dt_{crit}$	Exp. to 3750 V, $T_{vj} = 125^\circ\text{C}$		1000 V/ $\mu\text{s}$	

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Forward leakage current	$I_{DSM}$	$V_{DSM}, T_{vj} = 125^\circ\text{C}$			150	mA
Reverse leakage current	$I_{RSM}$	$V_{RSM}, T_{vj} = 125^\circ\text{C}$			150	mA

$V_{DRM}/V_{RRM}$  are equal to  $V_{DSM}/V_{RSM}$  values up to  $T_{vj} = 110^\circ\text{C}$

## Mechanical data

Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Mounting force	$F_M$		8	10	12	kN
Acceleration	a	Device unclamped			50	$\text{m/s}^2$
Acceleration	a	Device clamped			100	$\text{m/s}^2$

Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Weight	m				0.4	kg
Housing thickness	H	$F_M = 10 \text{ kN}, T_a = 25^\circ\text{C}$	34.8		35.4	mm
Surface creepage distance	$D_S$		38			mm
Air strike distance	$D_a$		21			mm

1) Maximum rated values indicate limits beyond which damage to the device may occur

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## On-state

### Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Average on-state current	$I_{T(AV)M}$	Half sine wave, $T_c = 70^\circ\text{C}$			350	A
RMS on-state current	$I_{T(RMS)}$				550	A
Peak non-repetitive surge current	$I_{TSM}$	$t_p = 10 \text{ ms}, T_{vj} = 125^\circ\text{C}, V_D = V_R = 0 \text{ V}$			$4.5 \times 10^3$	A
Limiting load integral	$I^2t$				$101 \times 10^3$	$\text{A}^2\text{s}$
Peak non-repetitive surge current	$I_{TSM}$	$t_p = 8.3 \text{ ms}, T_{vj} = 125^\circ\text{C}, V_D = V_R = 0 \text{ V}$			$4.85 \times 10^3$	A
Limiting load integral	$I^2t$				$98 \times 10^3$	$\text{A}^2\text{s}$

### Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
On-state voltage	$V_T$	$I_T = 1000 \text{ A}, T_{vj} = 125^\circ\text{C}$			3.5	V
Threshold voltage	$V_{(TO)}$	$I_T = 300 \text{ A} - 900 \text{ A}, T_{vj} = 125^\circ\text{C}$			1.2	V
Slope resistance	$r_T$				2.3	$\text{m}\Omega$
Holding current	$I_H$	$T_{vj} = 25^\circ\text{C}$			80	$\text{mA}$
		$T_{vj} = 125^\circ\text{C}$			60	$\text{mA}$
Latching current	$I_L$	$T_{vj} = 25^\circ\text{C}$			500	$\text{mA}$
		$T_{vj} = 125^\circ\text{C}$			200	$\text{mA}$

## Switching

### Maximum rated values <sup>1)</sup>

Parameter	Symbol	Conditions	min	typ	max	Unit
Critical rate of rise of on-state current	$di/dt_{crit}$	$T_{vj} = 125^\circ\text{C}, I_{TRM} = 1000 \text{ A}, f = 50 \text{ Hz}$			100	$\text{A}/\mu\text{s}$
Critical rate of rise of on-state current	$di/dt_{crit}$	$V_D \leq 3750 \text{ V}, I_{FG} = 2 \text{ A}, t_r = 0.5 \mu\text{s}$			1000	$\text{A}/\mu\text{s}$
Circuit-commutated turn-off time	$t_q$	$T_{vj} = 125^\circ\text{C}, I_{TRM} = 1000 \text{ A}, V_R = 200 \text{ V}, di_T/dt = -1 \text{ A}/\mu\text{s}, V_D \leq 0.67 \cdot V_{DRM}, dv_D/dt = 20 \text{ V}/\mu\text{s}$	700			$\mu\text{s}$

### Characteristic values

Parameter	Symbol	Conditions	min	typ	max	Unit
Recovery charge	$Q_{rr}$	$T_{vj} = 125^\circ\text{C}, I_{TRM} = 1000 \text{ A}, V_R = 200 \text{ V}, di_T/dt = -1 \text{ A}/\mu\text{s}$	900		2000	$\mu\text{As}$
Gate turn-on delay time	$t_{gd}$	$V_D = 0.4 \cdot V_{RM}, I_{FG} = 2 \text{ A}, t_r = 0.5 \mu\text{s}, T_{vj} = 25^\circ\text{C}$			3	$\mu\text{s}$

## Triggering

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Peak forward gate voltage	$V_{FGM}$				12	V
Peak forward gate current	$I_{FGM}$				10	A
Peak reverse gate voltage	$V_{RGM}$				10	V
Average gate power loss	$P_{G(AV)}$				see Fig. 9	

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Gate-trigger voltage	$V_{GT}$	$T_{vj} = 25^\circ C$			2.6	V
Gate-trigger current	$I_{GT}$	$T_{vj} = 25^\circ C$			400	mA
Gate non-trigger voltage	$V_{GD}$	$V_D = 0.4 \times V_{DRM}, T_{vj} = 125^\circ C$	0.3			V
Gate non-trigger current	$I_{GD}$	$V_D = 0.4 \times V_{DRM}, T_{vj} = 125^\circ C$	10			mA

## Thermal

*Maximum rated values<sup>1)</sup>*

Parameter	Symbol	Conditions	min	typ	max	Unit
Operating junction temperature range	$T_{vj}$				125	°C
Storage temperature range	$T_{stg}$		-40		140	°C

*Characteristic values*

Parameter	Symbol	Conditions	min	typ	max	Unit
Thermal resistance junction to case	$R_{th(j-c)}$	Double-side cooled $F_m = 8...12 \text{ kN}$			45	K/kW
	$R_{th(j-c)A}$	Anode-side cooled $F_m = 8...12 \text{ kN}$			85	K/kW
	$R_{th(j-c)C}$	Cathode-side cooled $F_m = 8...12 \text{ kN}$			95	K/kW
Thermal resistance case to heatsink	$R_{th(c-h)}$	Double-side cooled $F_m = 8...12 \text{ kN}$			7.5	K/kW
	$R_{th(c-h)}$	Single-side cooled $F_m = 8...12 \text{ kN}$			15	K/kW

**Analytical function for transient thermal impedance:**

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_{th i} (1 - e^{-t/t_i})$$

i	1	2	3	4
$R_{th i}$ (K/kW)	26.070	12.160	3.370	3.100
$\tau_i$ (s)	0.6439	0.0812	0.0161	0.0075

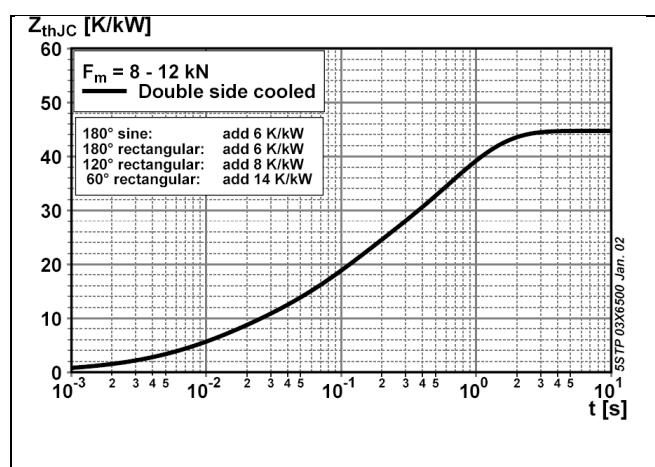


Fig. 1 Transient thermal impedance junction-to case.

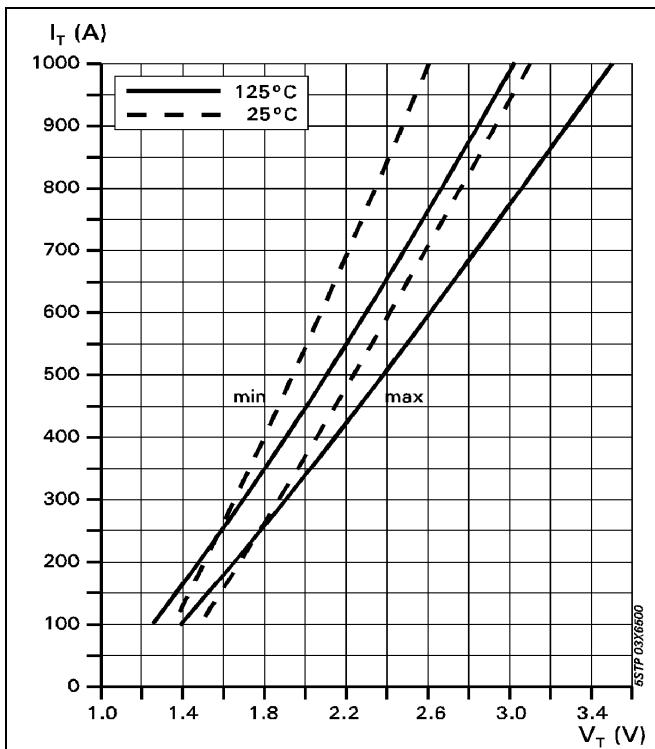


Fig. 2 Max. on-state voltage characteristics

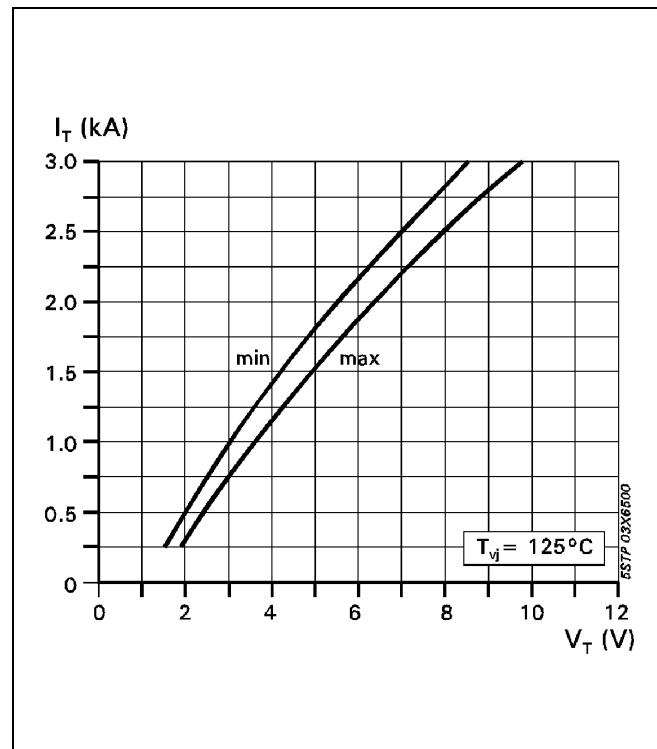
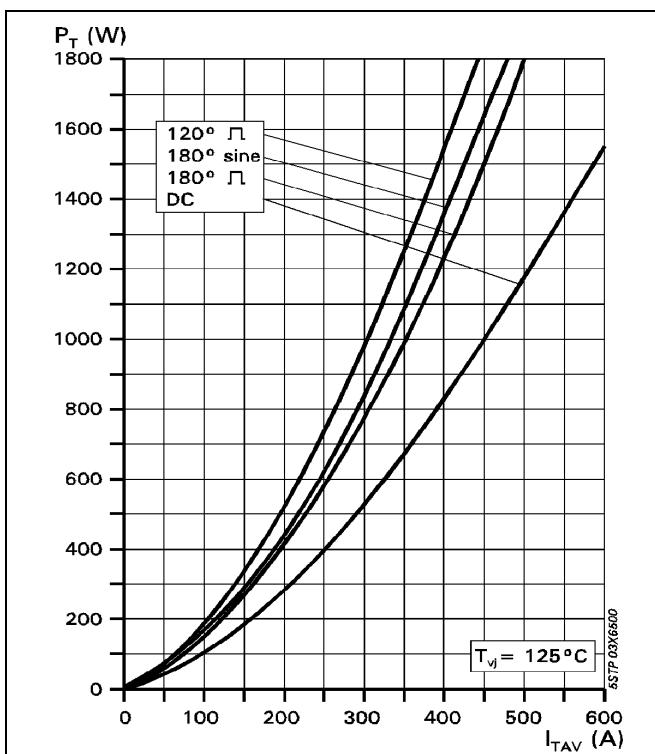
Fig. 3 On-state characteristics.  
 $T_j=125^\circ\text{C}$ , 10ms half sine

Fig. 4 On-state power dissipation vs. mean on-state current. Turn-on losses excluded.

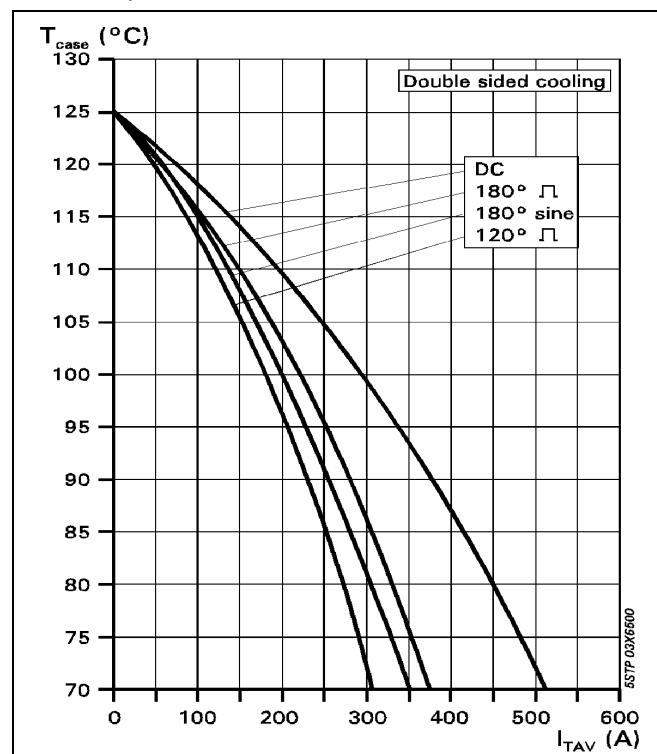
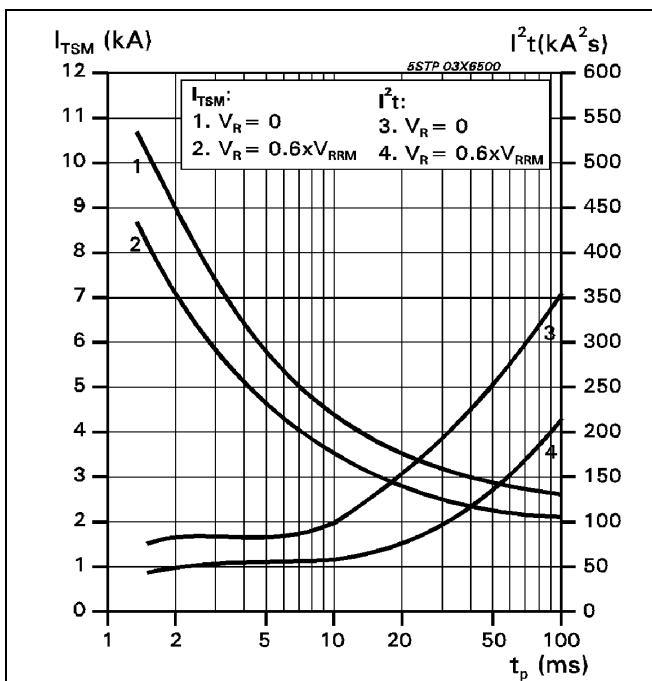
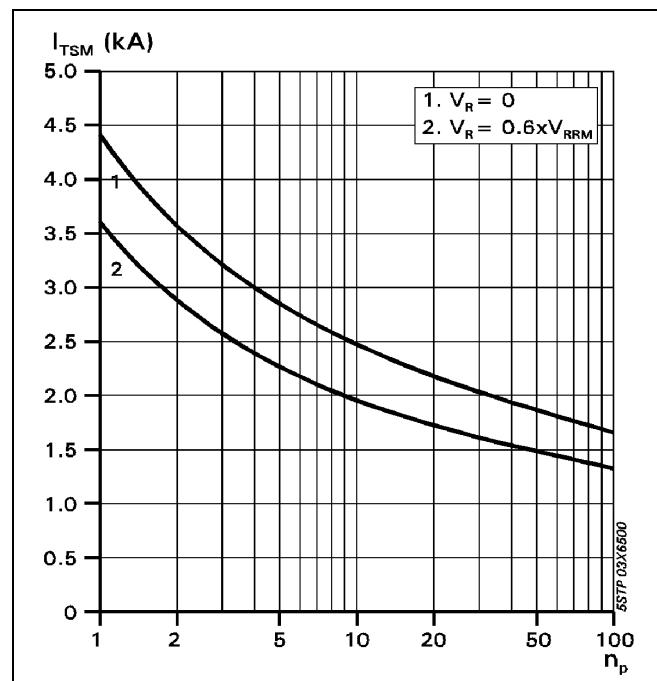


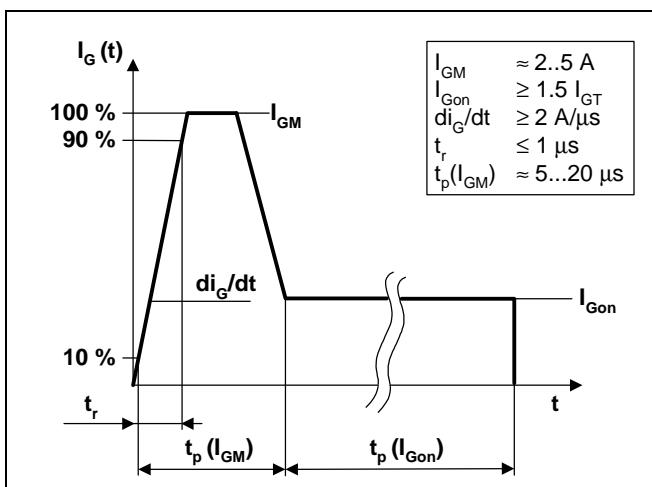
Fig. 5 Max. permissible case temperature vs. mean on-state current.



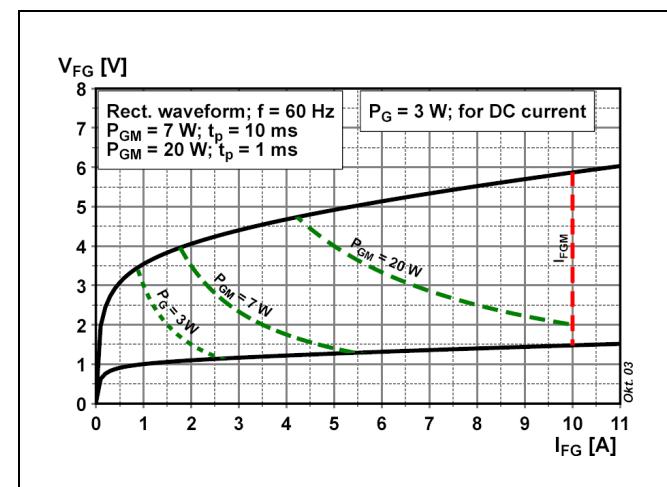
**Fig. 6** Surge on-state current vs. pulse length. Half-sine wave.



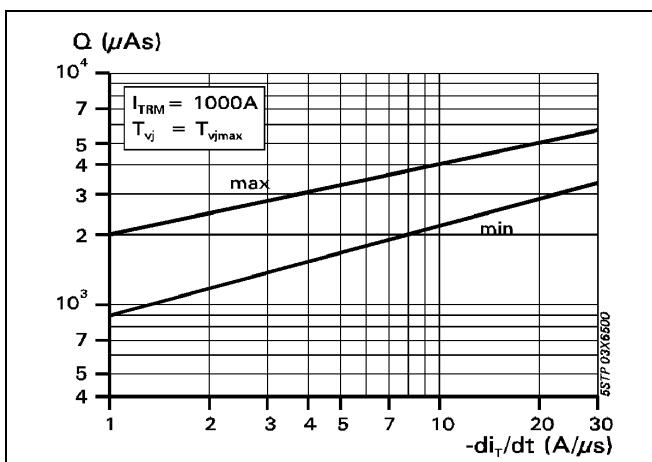
**Fig. 7** Surge on-state current vs. number of pulses. Half-sine wave, 10 ms, 50Hz.



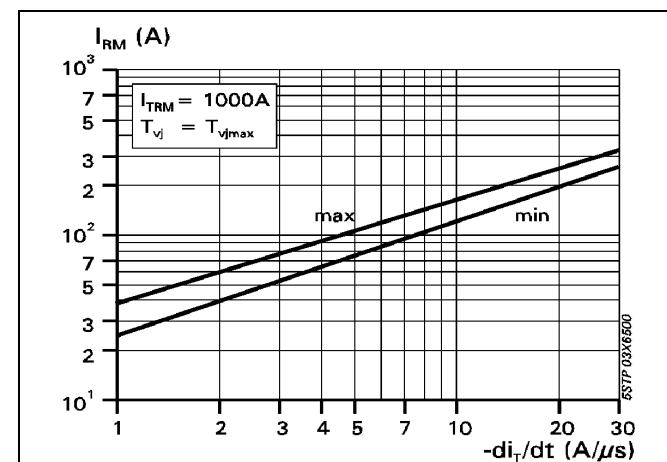
**Fig. 8** Recommended gate current waveform.



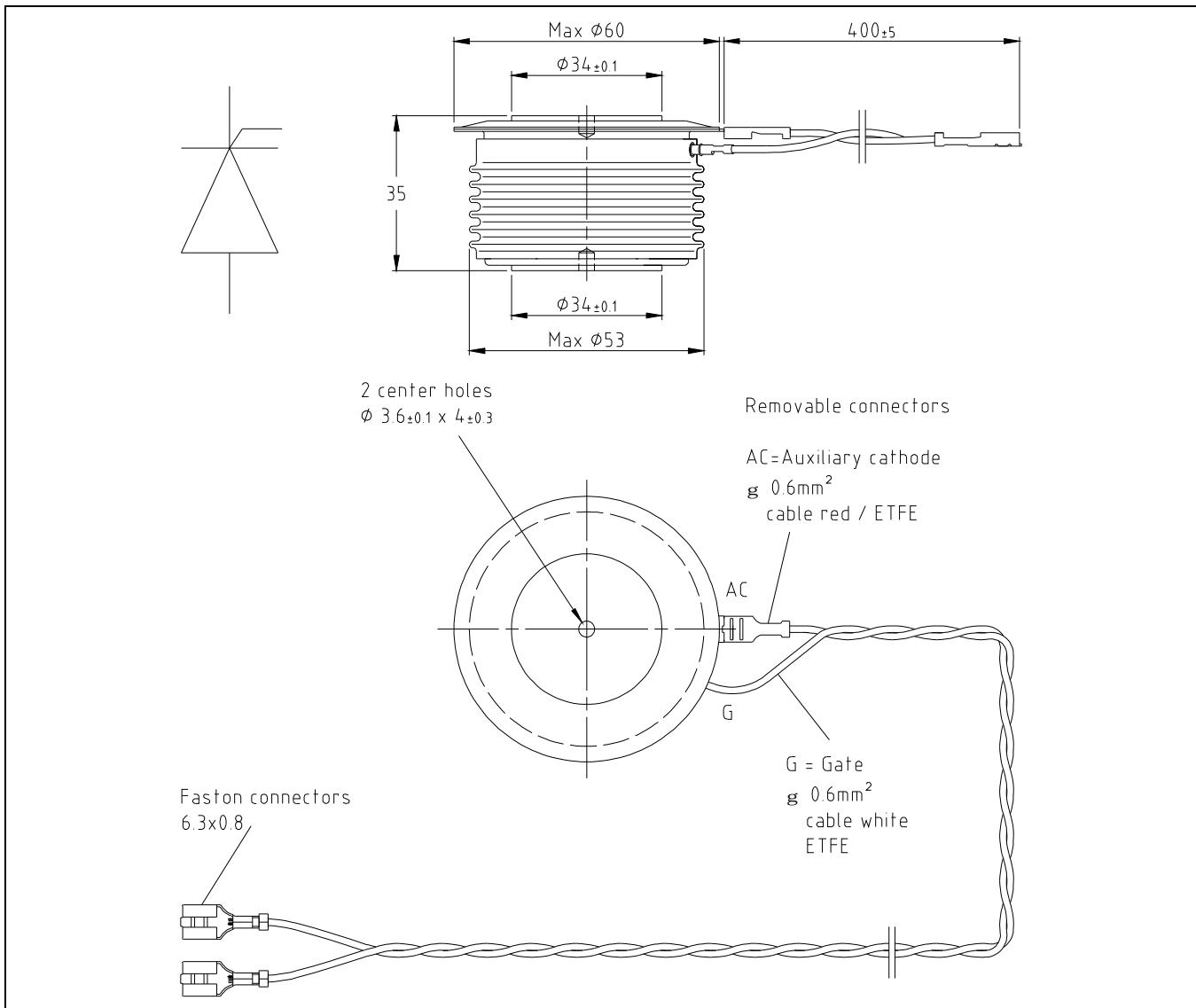
**Fig. 9** Max. peak gate power loss.



**Fig. 10** Recovery charge vs. decay rate of on-state current.



**Fig. 11** Peak reverse recovery current vs. decay rate of on-state current.



**Fig. 12** Device Outline Drawing.

### Related application notes:

Doc. Nr	Titel
5SYA2020	Design of RC-Snubber for Phase Control Applications
5SYA2034	Gate-drive Recommendations for PCT's
5SYA 2036	Recommendations regarding mechanical clamping of Press Pack High Power Semiconductors

Please refer to <http://www.abb.com/semiconductors> for actual versions.

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